

Search Notes



Application No.

10/602,383

Examiner

Hal D Wachsman

Applicant(s)

SANCHEZ PINA ET AL.

Art Unit

2857

SEARCHED

Class	Subclass	Date	Examiner
702	30,50,45, 47,24,25, 27,31,32, 52,55	10-29-04	lw
702	114,130, 138,140	10-29-04	lw
702	136,183, 100	10-29-04	lw
73	146,125, 126,134	10-30-04	lw
73	125,157, 159,35-02	10-30-04	lw
73	3504,37, 53-01,53-04	10-30-04	lw
73	53-05,54-01, 54-02,290R	10-30-04	lw
73	54-05,54-07, 54-09,54-11	10-30-04	lw
73	54-13,54-14, 61,73,152-18	10-30-04	lw
73	152-21,152-22, 152-29,861-02	10-30-04	lw
73	861-03,861-08, 861-12,861-14	10-30-04	lw
73	861-15,861-354, 861-356,861-357	10-30-04	lw
73	304C, 195,118.2	10-30-04	lw
340	612,618, 603,606,611	10-31-04	lw

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
700	266,281, 282	10-31-04	lw
701	99,102, 104	10-31-04	lw
324	663,664,667, 665,698	10-31-04	lw

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Plus search	8-18-04	lw
East text search	10-30-04	lw
IEEE database search	10-30-04	lw